Small Signal MOSFET

60 V, 380 mA, Single, N-Channel, SOT-23

Features

- ESD Protected
- Low R_{DS(on)}
- Surface Mount Package
- 2V Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Low Side Load Switch
- Level Shift Circuits
- DC-DC Converter
- Portable Applications i.e. DSC, PDA, Cell Phone, etc.

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

| Rating | Symbol | Value | Unit |
|---|-----------------------------------|----------------|------|
| Drain-to-Source Voltage | V _{DSS} | 60 | V |
| Gate-to-Source Voltage | V _{GS} | ±20 | V |
| | I _D | 380 270 | mA |
| | I _D | 320 230 | mA |
| Power Dissipation Steady State 1 sq in Pad Steady State Minimum Pad | P _D | 420 300 | mW |
| Pulsed Drain Current (t _p = 10 μs) | I _{DM} | 5.0 | Α |
| Operating Junction and Storage Temperature Range | T _J , T _{STG} | -55 to +150 | °C |
| Source Current (Body Diode) | Is | 300 | mA |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | TL | 260 | °C |
| Gate-Source ESD Rating (HBM, Method 3015) | ESD | 2000 | ٧ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 sq in pad size with 1 oz Cu.
- 2. Surface-mounted on FR4 board using 0.08 sq in pad size with 1 oz Cu.

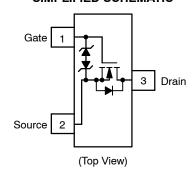


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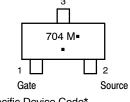
| V _{(BR)DSS} R _{DS(on)} MAX | | I _D MAX |
|--|---------------|--------------------|
| 60 V | 1.6 Ω @ 10 V | 380 mA |
| | 2.5 Ω @ 4.5 V | 360 IIIA |

SIMPLIFIED SCHEMATIC



MARKING DIAGRAM & PIN ASSIGNMENT Drain 3

SOT-23 CASE 318 STYLE 21



704 = Specific Device Code*

M = Date Code*

Pb-Free Package

(Note: Microdot may be in either location)
*Specific Device Code, Date Code or overbar
orientation and/or location may vary depending upon manufacturing location. This is a
representation only and actual devices may
not match this drawing exactly.

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|---------------------------|---------------------|-----------------------|
| 2N7002KT1G, 2V7002KT1G | SOT-23 (Pb-Free) | 3000 / Tape & Reel |
| 2N7002KT7G | SOT-23 (Pb-Free) | 3500 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

| Characteristic | Symbol | Max | Unit |
|---|-----------------|-----|------|
| Junction-to-Ambient - Steady State (Note 3) | $R_{\theta JA}$ | 300 | °C/W |
| Junction-to-Ambient - t ≤ 5 s (Note 3) | | 92 | |
| Junction-to-Ambient - Steady State (Note 4) | | 417 | |
| Junction-to-Ambient - t ≤ 5 s (Note 4) | | 154 | |

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--|--------------------------------------|---|---|-----|------|-----|-------|
| OFF CHARACTERISTICS | - | • | | | | | - |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | | 60 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | | | | 71 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, | T _J = 25°C | | | 1 | μΑ |
| | | V _{DS} = 60 V | T _J = 125°C | | | 10 | |
| | | V _{GS} = 0 V, V _{DS} = 50 V | T _J = 25°C | | | 100 | nA |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V | √ _{GS} = ±20 V | | | ±10 | μΑ |
| | | V _{DS} = 0 V, V | √ _{GS} = ±10 V | | | 450 | nA |
| | | V _{DS} = 0 V, \ | / _{GS} = ±5.0 V | | | 150 | nA |
| ON CHARACTERISTICS (Note 5) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}$ | I _D = 250 μA | 1.0 | | 2.3 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | 4.0 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V, | I _D = 500 mA | | 1.19 | 1.6 | Ω |
| | | V _{GS} = 4.5 V, I _D = 200 mA | | | 1.33 | 2.5 | |
| Forward Transconductance | 9FS | V _{DS} = 5 V, I _D = 200 mA | | | 530 | | mS |
| CHARGES AND CAPACITANCES | | | | | | | |
| Input Capacitance | C _{ISS} | | $V_{GS} = 0 \text{ V, f} = 1 \text{ MHz,}$ $V_{DS} = 20 \text{ V}$ | | 24.5 | 45 | pF |
| Output Capacitance | C _{OSS} | G.5 | | | 4.2 | 8.0 | |
| Reverse Transfer Capacitance | C _{RSS} | •DS · | | | 2.2 | 5.0 | |
| Total Gate Charge | Q _{G(TOT)} | | | | 0.7 | | nC |
| Threshold Gate Charge | Q _{G(TH)} | V _{GS} = 4.5 V | , V _{DS} = 10 V; | | 0.1 | | |
| Gate-to-Source Charge | Q_{GS} | I _D = 2 | 00 mA | | 0.3 | | |
| Gate-to-Drain Charge | Q_{GD} | | | | 0.1 | | |
| SWITCHING CHARACTERISTICS, V_{GS} | = V (Note 6) | | | | | | |
| Turn-On Delay Time | t _{d(ON)} | | | | 12.2 | | ns |
| Rise Time | t _r | V_{GS} = 10 V, V_{DD} = 25 V, I_{D} = 500 mA, R_{G} = 25 Ω | | | 9.0 | | |
| Turn-Off Delay Time | t _{d(OFF)} | | | | 55.8 | | |
| Fall Time | t _f | | | | 29 | | |
| DRAIN-SOURCE DIODE CHARACTER | ISTICS | | | | | | |
| Forward Diode Voltage | V _{SD} | V _{GS} = 0 V, | T _J = 25°C | | 0.8 | 1.2 | V |
| | | $I_S = 200 \text{ mA}$ $T_J = 85^{\circ}\text{C}$ | | | 0.7 | | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%

Surface-mounted on FR4 board using 1 sq in pad size with 1 oz Cu.
 Surface-mounted on FR4 board using 0.08 sq in pad size with 1 oz Cu.

^{6.} Switching characteristics are independent of operating junction temperatures

TYPICAL CHARACTERISTICS

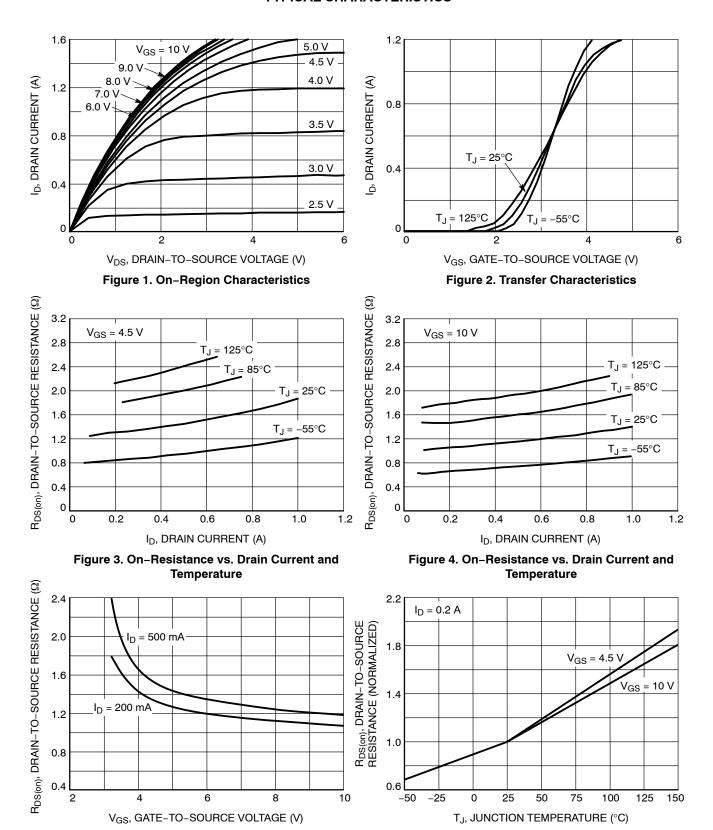


Figure 5. On-Resistance vs. Gate-to-Source Voltage

Figure 6. On–Resistance Variation with Temperature

TYPICAL CHARACTERISTICS

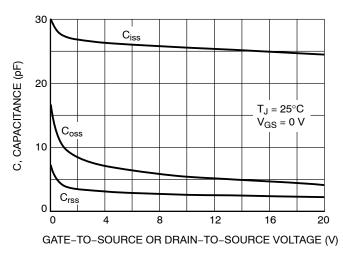


Figure 7. Capacitance Variation

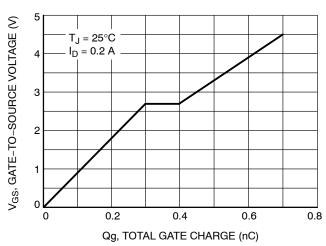


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

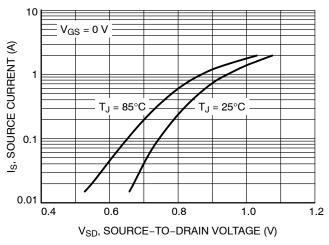


Figure 9. Diode Forward Voltage vs. Current

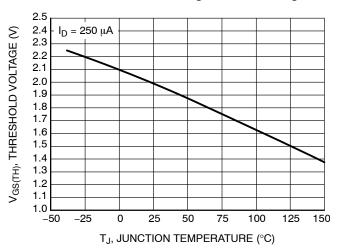


Figure 10. Threshold Voltage with Temperature

TYPICAL CHARACTERISTICS

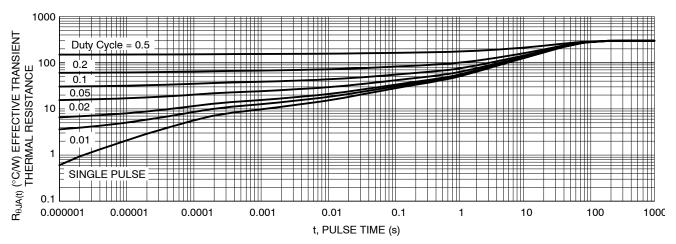


Figure 11. Thermal Response - 1 sq in pad

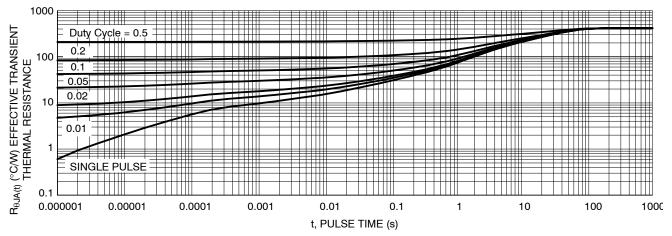
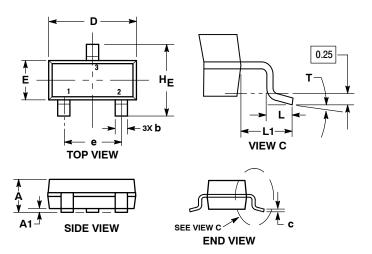


Figure 12. Thermal Response - minimum pad

PACKAGE DIMENSIONS

SOT-23 (TO-236) CASE 318-08 **ISSUE AS**



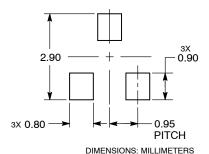
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS.
- MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH.
 MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF THE BASE MATERIAL.
 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH,
- PROTRUSIONS, OR GATE BURRS

| | М | ILLIMETE | RS | INCHES | | | |
|-----|------|----------|------|--------|-------|-------|--|
| DIM | MIN | NOM | MAX | MIN | NOM | MAX | |
| Α | 0.89 | 1.00 | 1.11 | 0.035 | 0.039 | 0.044 | |
| A1 | 0.01 | 0.06 | 0.10 | 0.000 | 0.002 | 0.004 | |
| b | 0.37 | 0.44 | 0.50 | 0.015 | 0.017 | 0.020 | |
| С | 0.08 | 0.14 | 0.20 | 0.003 | 0.006 | 0.008 | |
| D | 2.80 | 2.90 | 3.04 | 0.110 | 0.114 | 0.120 | |
| E | 1.20 | 1.30 | 1.40 | 0.047 | 0.051 | 0.055 | |
| е | 1.78 | 1.90 | 2.04 | 0.070 | 0.075 | 0.080 | |
| L | 0.30 | 0.43 | 0.55 | 0.012 | 0.017 | 0.022 | |
| L1 | 0.35 | 0.54 | 0.69 | 0.014 | 0.021 | 0.027 | |
| HE | 2.10 | 2.40 | 2.64 | 0.083 | 0.094 | 0.104 | |
| T | 0° | | 10° | 0° | | 10° | |

STYLE 21:

- PIN 1. GATE
 - SOURCE 2.
 - DRAIN

RECOMMENDED SOLDERING FOOTPRINT



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